

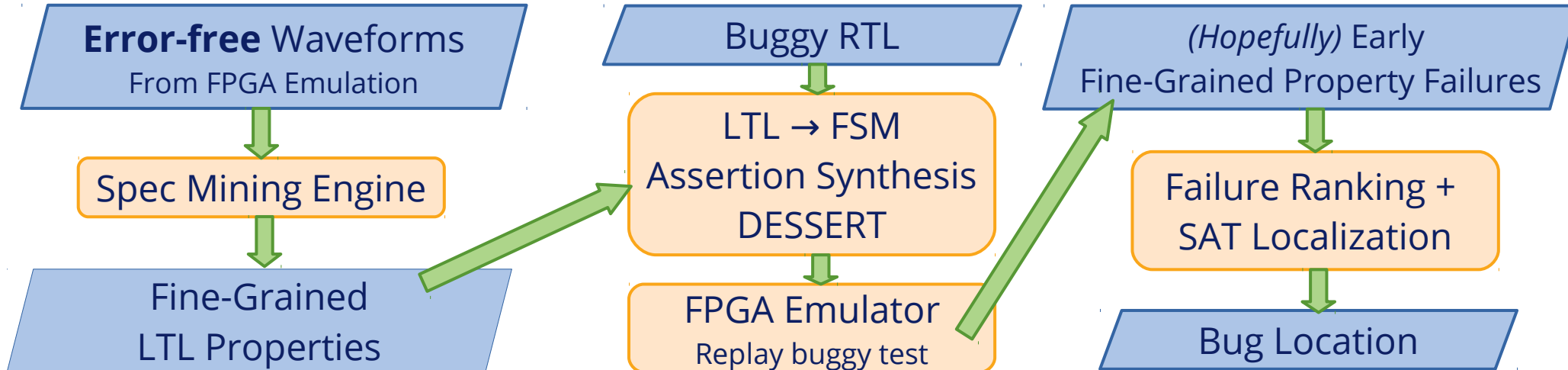
DRILLS: Debugging RTL Intelligently with Localization from Long Simulation

Specification mining using trace dumps derived from long-running FPGA emulation to localize bugs in complex digital designs

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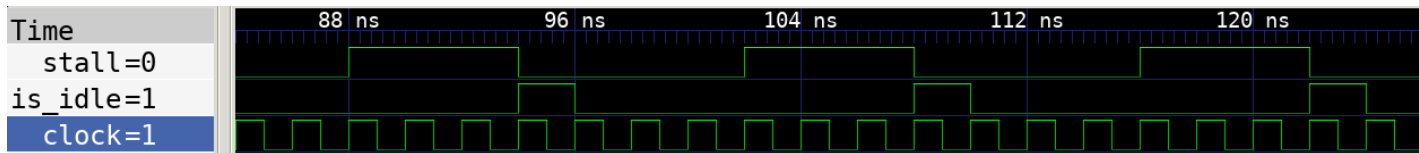
Plan

- **Problem:** given many error-free traces and one error trace, localize the likely bug location by module or line of RTL and find the fine-grained mined properties which were violated.
- Specification mining [Li '10] is a technique to extract fine-grained ($\Sigma = 2,3$) LTL properties (based on a set of templates) from execution traces
 - We will add additional LTL templates, and will apply this technique to large designs



Current Status + TODO

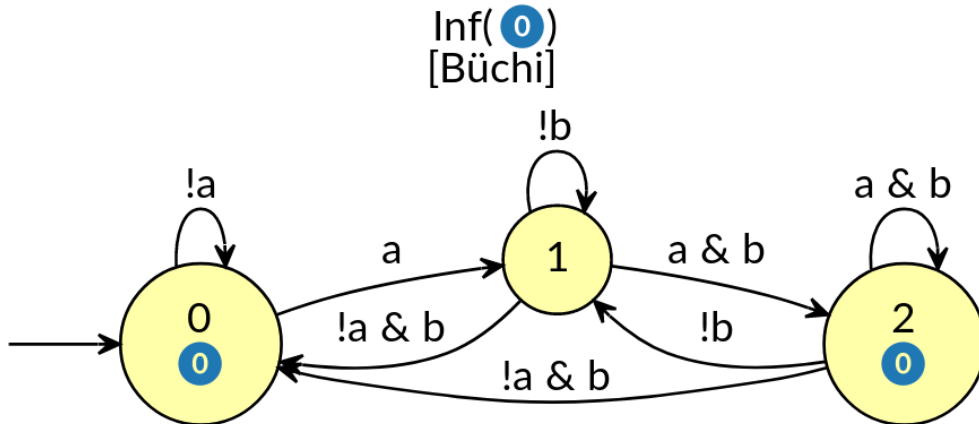
- Working VCD parser and LTL property miner (for 2 property templates)
 - **Alternating**: $\Delta a \textbf{A} \Delta b$
 - **Until**: $\textbf{G}(\Delta a \rightarrow \textbf{X} (a \textbf{U} \Delta b))$
 - **Next**: $\textbf{G}(\Delta a \rightarrow \textbf{X} \Delta b)$
 - **Eventual**: $\textbf{G}(\Delta a \rightarrow \textbf{X} \textbf{F} \Delta b)$
- Capable of mining properties from chisel-examples and riscv-mini
 - Next: `[['TOP.Tile.core.dpath.csr_io_stall', 'TOP.Tile.core.dpath.stall', 'TOP.Tile.core.dpath.csr.io_stall'], ['TOP.Tile.icache.is_idle']]`



Questions

- Is there a systematic way to go from LTL property to 'monitor automaton'?
 - Right now, the mining functions are very explicit and need hand-constructed automaton
 - Spot can emit automata for an LTL property, but it needs to be modified for finite-length traces

Deterministic automaton with 3 states and 8 edges.



- Example for $G(a \rightarrow XF b)$
- State-based acceptance only works for infinite-length traces that visit accepting states infinitely often
- We need to augment the automata with a 'num_patterns_seen' var
- Q: how to prune mined LTL properties?